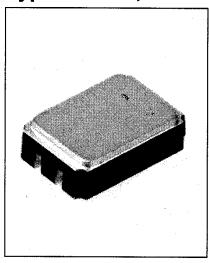
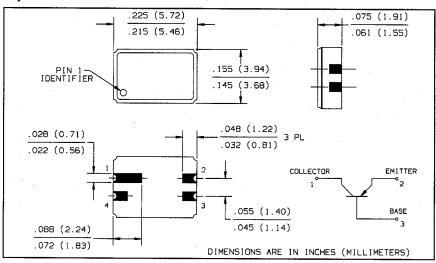


# Surface Mount PNP General Purpose Transistor Type TX, IXV, 2N2907AUA





#### **Features**

- Ceramic surface mount package
- Miniature package to minimize circuit board area
- · Hermetically sealed
- Qualification per MIL-PRF-19500/291

#### Description

The TX/TXV2N2907AUA is a hermetically sealed ceramic surface mount general purpose switching transistor. The miniature four pin ceramic package is ideal for designs where board space and device weight are important design considerations. The "UA" suffix denotes the 4 terminal leadless chip carrier package, type "A" per MIL-PRF-19500/291.

Typical screening and lot acceptance tests are provided on page 13-4. The Burn-in condition is  $V_{CB}=30$  V,  $P_D=400$  mW,  $T_A=25^{\circ}$  C, t=80 hrs. Refer to MIL-PRF-19500/291 for complete requirements. In addition, the TX and TXV versions receive 100% thermal response testing.

When ordering parts without processing, do not use a JAN prefix.

### Absolute Maximum Ratings (T<sub>A</sub> = 25° C unless otherwise noted)

Collector-Base voltage	60 V
Collector-Emitter Voltage	60 V
Emitter-Base Voltage	5.0 V
Collector Current-Continuous	00 mA
Operating Junction Temperature (T <sub>J</sub> )65° C to +2	
Storage Junction Temperature (T <sub>stg</sub> )65° C to +2	
Power Dissipation @ T <sub>A</sub> = 25° C	0.4 W
Power Dissipation @ T <sub>C</sub> = 25° C	6 W <sup>(1)</sup>
Soldering Temperature (vapor phase reflow for 30 sec.)	
Soldering Temperature (heated collet for 5 sec.).	
Notes:	
(4) 50	

(1) Derate linearly 6.6 mW/° C above 25° C.

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## Types TX, TXV, 2N2907AUA

**Electrical Characteristics** ( $T_A = 25^{\circ}$  C unless otherwise noted)

SYMBOL	PARAMETER	MIN	MAX	UNIT	TEST CONDITIONS
Off Charac	teristics			1 - N	
V <sub>(BR)CBO</sub>	Collector-Base Breakdown Voltage	60		٧	$I_C = 10 \mu\text{A}, I_E = 0$
V <sub>(BR)CEO</sub>	Collector-Emitter Breakdown Voltage	60		V	$I_C = 10 \text{ mA}, I_B = 0^{(2)}$
V <sub>(BR)EBO</sub>	Emitter-Base Breakdown Voltage	5.0		٧	I <sub>E</sub> = 10 μA, I <sub>C</sub> = 0
Ісво	Collector-Base Cutoff Current		10	nA	V <sub>CB</sub> = 50 V, I <sub>E</sub> = 0
	11		10	μΑ	V <sub>CB</sub> = 50 V, I <sub>E</sub> = 0, T <sub>A</sub> = 150° C
ICES	Collector-Emitter Cutoff Current		50	nA	V <sub>CE</sub> = 50 V
lebo	Emitter-Base Cutoff Current	-	50	nA	V <sub>EB</sub> = 4.0 V, I <sub>C</sub> = 0
On Charac	teristics				
hFE	Forward-Current Transfer Ratio	75		-	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 0.1 mA
		100	450	-	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 1.0 mA
		100		-	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 10 mA
		100	300		V <sub>CE</sub> = 10 V, I <sub>C</sub> = 150 mA <sup>(2)</sup>
		50		_	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 500 mA <sup>(2)</sup>
		50		-	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 1.0 mA, T <sub>A</sub> = -55° C
V <sub>CE(SAT)</sub>	Collector-Emitter Saturation Voltage		0.40	٧	I <sub>C</sub> = 150 mA, I <sub>B</sub> = 15 mA <sup>(2)</sup>
	4.00		1.60	V	I <sub>C</sub> = 500 mA, I <sub>B</sub> = 50 mA <sup>(2)</sup>
V <sub>BE(SAT)</sub>	Base-Emitter Saturation Voltage		1.30	V	I <sub>C</sub> = 150 mA, I <sub>B</sub> = 15 mA <sup>(2)</sup>
			2.60	٧	I <sub>C</sub> = 500 mA, I <sub>B</sub> = 50 mA <sup>(2)</sup>
Small-Sign	al Characteristics				
h <sub>fe</sub>	Small Signal Forward Current Transfer Ratio	100		-	$V_{CE} = 10 \text{ V}, I_{C} = 1.0 \text{ mA}, f = 1.0 \text{ kHz}$
lh <sub>fe</sub> l	Small Signal Forward Current Transfer Ratio	2.0			V <sub>CE</sub> = 20 V, I <sub>C</sub> = 50 mA, f = 100 MHz
Cobo	Open Circuit Output Capacitance		8.0	pF	V <sub>CB</sub> = 10 V, 100 kHz ≤ f ≤ 1.0 MHz
C <sub>ibo</sub>	Input Capacitance (Output Open Capacitance)		30	pF	V <sub>EB</sub> = 2.0 V, 100 kHz ≤ f ≤ 1.0 MHz
Switching	Characteristics		·		
ton	Turn-On Time		45	ns	V <sub>CC</sub> = 30 V, I <sub>C</sub> = 150 mA, I <sub>B1</sub> = 15 mA
toff	Turn-Off Time		300	ns	V <sub>CC</sub> = 30 V, I <sub>C</sub> = 150 mA, I <sub>B1</sub> = I <sub>B2</sub> = 15 mA

<sup>(2)</sup> Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%